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Local structural models of complex oxygen- and hydroxyl-rich GaP/InP(001) surfaces

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We perform density-functional theory calculations on model surfaces to investigate the interplay between the morphology, electronic structure, and chemistry of oxygen- and hydroxyl-rich surfaces of InP(001) and GaP(001). Four dominant local oxygen topologies are identified based on the coordination environment: $M$–O–M and $M$–O–P bridges for the oxygen-decorated surface; and $M$–[OH]–$M$ bridges and atop $M$–OH structures for the hydroxy-decorated surface ($M$=In,Ga). Unique signatures in the electronic structure are linked to each of the bond topologies, defining a map to structural models that can be used to aid the interpretation of experimental probes of native oxide morphology. The $M$–O–M bridge can create a trap for hole carriers upon imposition of strain or chemical modification of the bonding environment of the $M$ atoms, which may contribute to the observed photocorrosion of GaP/InP-based electrodes in photoelectrochemical cells. Our results suggest that a simplified model incorporating the dominant local bond topologies within an oxygen adlayer should reproduce the essential chemistry of complex oxygen-rich InP(001) or GaP(001) surfaces, representing a significant advantage from a modeling standpoint.

I. INTRODUCTION

Photoelectrochemical production of hydrogen using sunlight and water represents an attractive approach for environmentally benign chemical storage of solar energy\(^1\). However, optimizing semiconductor-based photoelectrode materials for hydrogen evolution has proven extremely difficult, in part because the microscopic details of the chemical processes active on the exposed photoelectrode remain poorly understood, as does the connection of these processes to the specific electronic and atomic structures of the semiconductor surface and interface\(^2\)–\(^4\). This is further complicated by the range of materials properties that must be simultaneously satisfied, including a band gap matched to the visible spectrum; proper band-edge alignment for driving the water redox reaction at the interface; good carrier mobility; stability under operating conditions in an electrolyte solution; and potential for catalyzing the surface water-splitting reaction\(^1,3\).

At present, the most efficient photoelectrochemical devices are based on III-V semiconductor photocathodes, with the highest rates of hydrogen generation achieved using a polar (001) surface of $\text{Ga}_x\text{In}_{1−x}\text{P}$\(^5\). Unfortunately, efficiency comes at the expense of short device lifetime due to fast degradation of the electrode\(^6\)–\(^12\). In order to tune stability and reactivity, a better understanding of the morphology and composition of the semiconductor surface under realistic environmental conditions is required; structural features can then be linked to specific electronic properties relevant to photocatalysis and photocorrosion. Of particular interest is the role of surface oxygen and hydroxyl, which are known to be present in high concentrations on exposed polar surfaces of many III-V semiconductors but are often neglected in idealized models, in part due to the complexity of the surface morphology. It has been suggested that the stability of some III-V surfaces in an electrolyte, as well as the photocatalytic water-splitting activity itself, may be tied to the existence of this surface oxygen\(^9,11,13–16\). Such a connection between water splitting and surface oxygen is also consistent with our initial results on the InP(001)-water interface\(^17\).

In this work, we aim to provide a detailed description of the interaction of chemisorbed oxygen and hydroxyl with model III-V semiconductor photocathodes, and of the nucleation of surface oxide and hydroxide films from component elements. Since alloys of GaP and InP demonstrate the highest overall conversion efficiency of any known material, we have focused our study on (001) surfaces of these two materials, which individually have known water-splitting activity\(^5,16,18–22\) and represent endpoints in the $\text{Ga}_x\text{In}_{1−x}\text{P}$ composition phase diagram. In addition, GaP and InP are widely studied semiconductor materials with key applications in optoelectronics and photovoltaics. Accordingly, understanding the nature of adsorbed oxygen on these surfaces is of further importance to these communities. To this end, we have performed extensive total-energy calculations based on density functional theory to explore the structure, stability, and chemistry of oxygen- and hydroxyl-rich InP(001) and GaP(001) surfaces.

Although dissociative chemisorption of molecular oxygen is known to take place at III-V surfaces at ambient temperature\(^23\), experiments suggest that different local thermal and electrochemical growth conditions lead to significant variation in the composition and morphology of the resulting native oxide films\(^9,10,24–30\). The discrepancies point to a complex free energy surface featuring competing variants whose expression is determined by a combination of kinetics and thermodynamics. These may mix regionally within a single sample, or else form the structural motifs of an amorphous oxide layer. Since these complexities make specific determination of a single dominant oxide structure difficult, the goal of this work is to identify those structural motifs that are most likely to exist in real oxide layers on InP(001) and GaP(001). As we will demonstrate, similar dominant local bond topologies are evident across all of our tested surfaces, and can be related to local geometries within bulk oxides derived...
from In, Ga, and P. Our calculation method permits us to isolate the corresponding electronic signatures and relative stability of each topology. Notably, many of these signatures should be reflected in surface-sensitive spectroscopic measurements.

II. METHODS

Results are obtained using density functional theory and a plane-wave basis set, as implemented in the Quantum-Espresso code\textsuperscript{31}. The Perdew-Burke-Ernzerhof (PBE) exchange-correlation functional was used\textsuperscript{32}. Ultrasoft pseudopotentials\textsuperscript{33} were employed with plane-wave and charge-density cutoffs of 30 and 240 Ry, respectively, and with semi-core \textit{d} states included in the valence descriptions for In and Ga. We inserted 12 Å of vacuum separation between periodic slab images. Nine-layer slabs exposing the (001) surface were used, with the odd number to ensure both surfaces were In/Ga-rich. The bottom surface was terminated with a hydrogen bridging every other pair of metal atoms along [110], plus an additional atop hydrogen on every metal atom. This choice of surface termination was motivated by the results of Ref.\textsuperscript{34}, where exact charge compensation was found to be necessary for adequate passivation of the surface of a layered polar structure. Tests confirmed that the corresponding surface states lay inside the band edges. All atoms were relaxed independently except for the bottom two semiconductor layers, which were fixed to the bulk geometry, and the hydrogen termination layer. A 6\times6 \textbf{k}-point mesh was used in the slab plane for the (2\times2) surfaces, with one \textbf{k}-point perpendicular to the slab. For the other surface reconstructions, the in-plane \textbf{k}-point mesh was adjusted to maintain the same density.

Three sets of surface models are used to explore different coverages and morphologies for O/OH adsorption: a M-rich mixed-dimer \(\delta(2 \times 4)\) reconstruction \((M=\text{In}, \text{Ga})\); a regular rectangular lattice of \(M-M\) dimers in a \((1 \times 2)\) reconstruction; and a collection of \((2 \times 2)\) surfaces generated by relaxing initially unreconstructed samples under high O/OH loading. Defining the surface coverage \(\theta\) as the ratio of adsorbrates to pre-relaxation surface atoms, these three correspond to \(\theta=0.1, 0.5, \) and \(1,\) respectively.

The choice of surface reconstruction for the dilute coverage limit \((\theta=0.1)\) was motivated by the observation that the two most common reconstructions of InP(001) and GaP(001) under ambient conditions are the M-rich mixed-dimer \(\delta(2 \times 4)\) and the P-rich \((2 \times 1)\), depending on the specific growth environment\textsuperscript{35-38}. Of these, experiments on InP(001) have shown that the P-rich surface features stable P-P dimers that exhibit weak oxygen uptake at ambient temperature, whereas the M-rich mixed-dimer \(\delta(2 \times 4)\) surface reacts readily with oxygen\textsuperscript{23}. Since we are interested in surface oxygen binding, we therefore consider only the M-rich surface in the present study. The \(M\)-rich mixed-dimer \(\delta(2 \times 4)\) surface has also been observed in the ternary InGaP(001) alloy\textsuperscript{44}. It is worth mentioning that theoretical \textit{ab initio} studies have predicted an additional surface Ga-dimer \((2 \times 4)\) reconstruction of GaP(001) for very Ga-rich growth environments\textsuperscript{35,37,38,42}; however, as this has not been realized experimentally, we restrict our study to the mixed-dimer \(\delta(2 \times 4)\) reconstruction found in both materials. The topologically distinct high-symmetry sites we tested are shown in Fig. 1.

Dense oxygen and hydroxyl coverage \((\theta=1)\) was also considered in order to better model the initial stages of native oxide/hydroxide nucleation upon higher oxygen or hydroxyl loading. Recognizing that InP/GaP(001) surfaces could exhibit a very different reconstruction under such conditions, model structures were generated by placing oxygen atoms and hydroxyl groups in high-symmetry sites of initially unreconstructed \(M\)-rich \((2 \times 2)\) surface slabs, from which atoms were allowed to relax to local-minimum configurations. Atop, hollow, and both bridge sites were tested (see panel inset, Fig. 2). In each case, the four adsorbate positions were perturbed independently to generate as many unique surfaces as possible. Although not an exhaustive search of the parameter space, this method enabled generation of seven additional oxygen-rich and three additional hydroxyl-rich surface structures, shown in Fig. 2. Since the final configurations do not always reflect the initial site symmetry, we avoid confusion by adopting a notation that indexes surface morphologies with a letter corresponding to the initial adsorption site \((A=\text{atop}, X=\text{bridge } \text{x}, Y=\text{bridge } \text{y}, H=\text{hollow})\). An additional numerical index is appended to distinguish the various configurations for the \(A\) and \(H\) symmetry sites in the case of the oxygen-rich surfaces in Fig. 2a.

Last, a regular rectangular lattice of \(M-M\) dimers in a \((1 \times 2)\) pattern \((\theta=0.5)\) was included, as this is the simplest representative model for InP/GaP(001) surface dimerization. Such dimerization is the dominant characteristic not only of the mixed-dimer \(\delta(2 \times 4)\) reconstruction, but also in additional competing (001) surface reconstructions in \(M\)-rich environments, such as those expressed under non-equilibrium growth conditions where kinetics are expected to dominate\textsuperscript{45}. Here, oxygen was tested in the surface bridge y site and in a subsurface site between \(M\) and \(P\); hydroxyl adsorption was tested in the surface bridge y site and at the \(M\) atop site (see panel inset, Fig. 2 for designations of high-symmetry sites). We find that in many instances, this simplified model based on a lattice of \(M-M\) dimers captures much of the physics of the more complex surfaces due to the local nature of the oxygen electronic signature.

Adsorption energies were calculated as \(\Delta E = E_{\text{surf+ads}} - E_{\text{surf}} - E_{\text{ads}},\) where \(E_{\text{surf+ads}}, E_{\text{surf}},\) and \(E_{\text{ads}}\) are the reference energies of the adsorbed system, clean surface, and gas-phase adsorbate (O or OH), respectively. For dilute adsorption on the mixed-dimer \((2 \times 4)\) reconstruction, the reference for the clean surface is the re-
FIG. 1. Tested adsorption sites for oxygen and hydroxyl ($\theta = 0.1$) on the mixed-dimer $\delta(2 \times 4)$ reconstruction of InP/GaP(001). Triangles/squares represent $M/P$ atoms. Larger size and darker shading reflects higher relative atomic position.

constructed surface without the adsorbate; for all other cases, including the ($2 \times 2$) and ($1 \times 2$) surfaces, the reference is the dimerized ($1 \times 2$) surface without the adsorbate. Two different gas adsorbate references were used: (1) $O_2$, and (2) $H_2/H_2O$. For the projected densities of states, the in-plane $k$-point mesh density was increased fourfold in each direction. Levels were aligned across different surfaces by matching the average electrostatic potential in the slab center, similar to Ref. 46. Additional tests using an alignment scheme based on the indium $d$ levels in the slab center gave closely compatible results.

III. SURFACE STRUCTURE AND ENERGETICS

A. Oxygen on In/Ga-rich InP/GaP(001)

Formation energies $\Delta E$ for stable oxygen adsorption on each of the tested surfaces are reported for both InP and GaP in Fig. 3. The energies are given with respect to two different gas reference states: (1) $O_2$, and (2) $H_2/H_2O$. Five local oxygen bond topologies can be identified from the relaxed structures: (1) $M-O-P$; (2) $M-O-M$; (3) a three-way $M_2-O-P$ bridge; (4) a three-way $M_2-O-M$ bridge; and (5) $P=O$, which appears only on the $M-P$ surface dimer of the mixed-dimer $\delta(2 \times 4)$ reconstruction. Of these, the two-way bridges $M-O-P$ and $M-O-M$ are the most commonly observed and generally the most stable (exceptions are discussed below). The specific location of the adsorbed oxygen has only a minor impact on the energetics of the binding; rather, the stability is primarily determined by the bond topology. Oxygen adsorption is thermodynamically favored with respect to $O_2$ gas (dry atmospheric conditions; left axis in Fig. 3), in agreement with observations of spontaneous surface oxidation of InP(001) and GaP(001)$^{8,9,15,26}$. However, only Ga–O–Ga is thermodynamically favored with respect to $H_2/H_2O$ (right axis in Fig. 3), which is a better approximation for the operating conditions within a hydrogen-evolving photoelectrochemical cell with an aqueous electrolyte. It is worth emphasizing that oxide films grown at ambient temperatures are commonly far from equilibrium$^{24}$. As such, it is appropriate to include in any analysis not only the lowest-energy structure in Fig. 3, but also motifs which represent a somewhat larger range of energies.

The $M-O-P$ topology has a similar formation energy for GaP as for InP, generally within 0.2 eV. In the case of InP, In–O–P is also competitive with In–O–In. On the other hand, for GaP, Ga–O–Ga is clearly preferred over Ga–O–P by more than 0.5 eV. This can be traced to the higher strength and covalency of the Ga–O bond relative...
FIG. 3. Formation energies $\Delta E$ (eV per adsorbate) for stable geometries with oxygen adsorbed on (a) the mixed-dimer $\delta(2 \times 4)$ at the sites listed in Fig. 1 ($\theta = 0.1$); (b) the $(1 \times 2)$ model dimer surface ($\theta = 0.5$); and (c) the $(2 \times 2)$ reconstructed surface at the dense limit ($\theta = 1$) to generate the surfaces in Fig. 2a. Black solid (red broken) lines are for InP (GaP). Values are given with respect to H$_2$/O$_2$ (left axis) and H$_2$/H$_2$O (right axis) gas references (see Methods for details). The symbols correspond to the different constituent bond topologies indicated in the legend. In (a), adsorption on Site #4 of the mixed-dimer surface pushes the M–P dimer along [110] to equalize the three bond lengths, resulting in higher $E_{\text{ads}}$; other surfaces retain their basic structure.

to the In–O bond in these structures, which matches the trend for the M–P bonds in the corresponding bulk materials. Accordingly, we observe lower formation energies for oxygen-decorated GaP over InP at nearly all equivalent binding sites that contain M–O bonds, with the difference generally proportional to the M–O concentration (for instance, among the dense-coverage surfaces, the largest differences are found for A1, A2, A3, and Y). The same scenario is reflected in the bond lengths in InP and GaP, which differ on average by $\sim 0.35$ Å for Ga–O and In–O. One might also expect the P–O bond strength to be affected by the identity of the metal species to which the oxygen is bound. However, this does not seem to be the case, as O–P bond lengths are essentially identical for the In–O–P and Ga–O–P topologies. This hints at the intrinsically local nature of the M–O–P bond chemistry.

Collective examination of the various surface morphologies suggests that whereas the M–O–M motif in InP/GaP(001) can exist only at the surface, where neighboring In or Ga atoms are exposed to one another, the M–O–P motif can substitute for any existing M–P bond as long as the induced lattice strain can be accommodated. Based on results for the mixed-dimer $\delta(2 \times 4)$, this strain represents 35–40% expansion with respect to the bulk M–P distance. The mixed-dimer $(2 \times 4)$ can feature $M$–O–P as a surface motif, since a surface phosphorus atom is present. However, the $(1 \times 2)$ dimer and initially unreconstructed dense-coverage surfaces in (Figs. 2a, 3b, and 3c) contain no surface phosphorus. Instead, the expression of phosphorus-containing motifs on these reconstructions do not derive from surface-layer oxygen but rather from oxygen incorporation into the subsurface layer. Some structures (e.g., X) demonstrate significant surface corrugation as a consequence. Three different depths of M–O–P oxygen penetration are represented in Fig. 2. The X structure pushes some In/Ga atoms into a new surface layer, bridged by oxygen atoms to a phosphorus subsurface. The H$_2$ structure features oxygens directly below the primary M-rich surface layer. In H1, the oxygens sit below the subsurface phosphorus atoms. Notably, there is an inverse correlation between oxygen depth in these three surfaces and their corresponding $\Delta E$.

To gain a more direct assessment of the thermodynamics of oxygen incorporation into the subsurface layers, we also calculated the energetic cost of inserting oxygen into M–P bonds beneath the surface of the mixed-dimer $(2 \times 4)$ reconstruction. For the surface and first three subsurface layers, those calculations showed O$_2$-referenced formation energies of $-2.98/\sim-3.13$, $-2.49/\sim-2.59$, $-2.40/\sim-2.26$, $-2.26/\sim-2.26$ eV for InP(001)/GaP(001). Again, we observe an inverse correlation between the depth and corresponding $\Delta E$ for the first few layers, although the values appear to saturate quickly. Note that these values also favor oxygen incorporation in the bulk; however, they do not account for potentially unfavorable kinetics at ambient temperatures.

Two of the dense-coverage surfaces in Figs. 2a and 3c merit further mention. First, the X configuration has unexpectedly low $\Delta E$, particularly for InP. This is because the resulting surface reconstruction features formation of stable P–P dimers. Second, the Y configuration has a higher-than-expected $\Delta E$, despite being highly ordered and featuring only M–O–M bridge motifs, which the other samples show to be quite stable. This seeming inconsistency turns out to be connected to the lattice strain induced by symmetry constraints from simultaneous occupation of neighboring oxygen bridge sites. This is seen by comparing Y to the bridge Y configuration in the $(1 \times 2)$ dimer supercell, which has a lower surface adsorbate concentration of $\theta=0.5$. Since the $\theta=1$ Y surface forces the surface M–M distance to match the bulk distance, the change in this quantity upon lowering the surface adsorbate concentration acts as an indicator of the accompanying strain relaxation. For surface oxygen, the strain relaxation is substantial, with a 20–23% decrease in the M–M distance, and a corresponding change in the M–O–M bond angle from 157–158° to 113°. As discussed below, this strain also profoundly impacts the accompanying local electronic structure.

B. Hydroxyl on In/Ga-rich InP/GaP(001)

Oxygen adsorption could also occur via surface hydroxylation, particularly in a moisture-rich environment.
As such, the adsorption calculations were repeated for hydroxyl-decorated InP/GaP(001) surfaces. Compared to the oxygen-decorated case, the hydroxylated surface shows a simpler configurational phase space with fewer dominant local bond topologies.

Figure 4 shows the formation energies for stable adsorption of hydroxyl on our tested surfaces. We find three local oxygen bond topologies: a P–OH atop bond; a M–OH atop bond; and a M–[OH]–M bridge. For the mixed-dimer (2×4), the M–[OH]–M bridge shows a strong preference over the atop configurations, being thermodynamically favored by 0.6–0.7 eV. Interestingly, this is not consistent across the three categories of surfaces, indicating some dependence of the adsorption energy on the broader environment. For instance, the ordering is reversed for the (1×2) dimer surface. This is because the displacement constraints on the mixed-dimer (2×4) reconstruction that arise from surface atoms bound to the M–M dimer are not present for the dimerized (1×2) reconstruction. This permits energy-lowering surface buckling for the (1×2) reconstruction but not for the mixed-dimer (2×4), as detailed further below.

As we saw for the oxygen-adsorbed surface, GaP(001) consistently binds hydroxyl more strongly than InP(001) whenever a M–OH bond is present, owing to the relative strength of the Ga–O bond over the In–O bond. However, unlike the oxygen case, the strength of binding does not seem to scale with the number of M–OH bonds, since the bridge and atop topologies exhibit nearly identical behavior. Much like the P=O bond in Fig. 3a, the P–OH bond in Fig. 4a carries the same energy for both GaP and InP, confirming the validity of a local representation for this interaction.

Comparing Figs. 3 and 4, we find that hydroxyl adsorption on mixed-dimer δ(2×4) is energetically favored with respect to oxygen adsorption, assuming sufficient proton concentration. As such, the exposed outermost surface layer of GaP/InP(001) is likely to hydroxylate spontaneously. This agrees with recent calculations showing preferred hydroxylation on exposed (001) surfaces of InP nanowires, for instance. It is worth noting that the M–[OH]–P configuration is absent from Fig. 4, since we were unable to stabilize it; hydroxyl groups are thus likely to exist only as surface species except at very high concentrations.

Hydroxyl adsorption on the initially unreconstructed In/Ga-rich (2×2) InP/GaP(001) surface slab generated slightly different geometries for GaP(001) and InP(001), as shown in Fig. 2b. The structural differences between the hydroxylated InP(001) and GaP(001) surfaces can be traced to a symmetry-breaking distortion that occurs on GaP when neighboring bridge sites are occupied by hydroxyl groups. The –[OH]– bridge is not evenly shared between M atoms as it is for InP, but rather is weakly bound to one Ga atom and strongly to the other (e.g., for the Y configuration, the bond distances are 1.98 and 2.31 Å). In addition, the strong-binding Ga atom prefers to host two shorter Ga–[OH] bonds, leaving the weak-binding Ga atom with both longer Ga–[OH] bonds. The result is an alternating [OH]···[OH]–Ga–[OH] complex.

There is a second structural difference between GaP and InP that is seen only for the (1×2) dimer surface. GaP displays significant surface buckling that does not occur in InP, with one Ga atom rising out of the surface plane, 0.57 Å above its counterpart. Similar buckling is commonly observed in other semiconductor surfaces, and has been proposed as a surface structural motif in GaInP. Notably, this same type of buckling is observed on the (1×2) dimer surface of both GaP and InP upon adsorption of a single atop OH on the M–M dimer, although the out-of-plane displacement of the surface M atom is somewhat smaller in this case (0.30 Å for GaP; 0.23 Å for InP). In each instance, the buckling results from sp² hybridization of one of the M edge atoms and transfer of charge to the other M atom, which acquires atomic-like p orbitals. The charge redistribution also breaks the symmetry in the two sets of P–M–O angles spanned by the edge M atoms and their subsurface P atoms (the angles become 94° and 117° for Ga–[OH]–Ga; 95° and 116° for Ga–Ga–[OH]; and 95° and 114° for In–In–[OH]). An additional possible consequence of this buckling is to expose a neighboring subsurface phosphorus atom to easier adatom attack.

The H configuration in Figs. 2b and 4c features M–[OH]–M bridge hydroxyls oriented along [110] (δ), in contrast with the oxygen-decorated case, where M–O–M bridges were found oriented only along [110] (γ). The reason for this is that unlike oxygen, insertion of hydroxyl in a bridge changes the bulk equilibrium M–M bond dis-
IV. LOCAL BOND GEOMETRIES

Having cast the complex morphologies of oxygen- and hydroxyl-rich surfaces in terms of local bond topologies, we use our generated surfaces to isolate commonalities in the associated bond geometries. Structural features can then be compared to measurements in bulk oxides and hydroxides to assess the validity and universality of our models, and to provide potential insight into the local bond configurations that can lead to initial nucleation of native oxide and hydroxide films. In doing so, we find compelling structural parallels between our results and the reported corrosion byproducts of InP and GaP photoelectrodes, namely, $M_2O_7$-type oxides and $MPO_4$-type phosphates, as well as $M(OH)_3$ and $P_2O_5$. Similar products are reported for the In$_{0.5}$Ga$_{0.5}$P alloy.\(^7,58\)

Fig. 5 shows histograms of key bond angles and bond distances in the $M$–$O$–$M$, $M$–$O$–$P$, and $M$–$[OH]$–$M$ bond topologies, compiled from the entire set of InP and GaP samples we investigated. Although one should be careful drawing quantitative conclusions, certain qualitative features can nevertheless be extracted for comparison among bond topologies and with experimentally reported values. Results for InP and GaP are qualitatively similar, with the exception of the different equilibrium $M$–$O$ bond distances (in contrast, the $O$–$P$ bond lengths in Fig. 5b are the same for the two). The distribution of $M$–$O$ bond distances for $M$–$[OH]$–$M$ is also wider for GaP than for InP, which derives from the symmetry-breaking distortion already described.

Key differences are evident in the distributions of the bond angles and when comparing $M$–$O$–$P$ and $M$–$O$–$M$ topologies. For instance, the range of bond angles for $M$–$O$–$M$ (Fig. 5c) is generally broader than for $M$–$O$–$P$ (Fig. 5a), indicating the greater covalency of the $O$–$P$ bond. Nevertheless, the $M$–$O$–$M$ distribution has more internal fine structure. The $M$–$O$–$P$ angles show possibly two peaks appearing around 125 and 135, whereas the $M$–$O$–$M$ angles have what appears to be three distinct peaks around 100°, 120°, and 160°. Similarly, the distributions of $M$–$O$ bond distances show discernible fine structure for $M$–$O$–$M$ but not for $M$–$O$–$P$, with two clear peaks visible for InP and possibly three for GaP.

The fine structure in our $M$–$O$–$M$ distributions correlates to different local configurations or hybridizations. In Fig. 5c, the $M$–$O$–$M$ bond angle peak near 160° represents a bridge oxide that is strained by symmetry constraint, e.g., $Y \ (\theta=1)$. This bond angle is not found in the bulk oxides, probably because of the associated strain energy. However, the other two peaks (around 100° and 120°) are common across a variety of tested surfaces, and closely match reported values for the common polymorphs $\beta$-$Ga_2O_3$ and bixbyite $In_2O_3$, as well as In–O–In angular distributions in amorphous $In_2O_3$. Similarly, the Ga–O bond distances in Fig. 5d show peak splitting reminiscent of the different intrinsic oxygen-bridge geometries of GaO$_4$/GaO$_6$ in $\beta$-$Ga_2O_3$, and the longer-
distance In–O bonds are close to the reported values for bixbyite In$_2$O$_3$.\textsuperscript{52} In addition, the shorter-distance In–O distribution resembles the shape reported for amorphous In$_2$O$_3$.\textsuperscript{57}

The internal structure of the M–O–P bond angle histogram (Fig. 5a) is somewhat less resolvable than for M–O–M (Fig. 5d); nevertheless, the two apparent peak locations appear to match discrete values for hydrous and anhydrous InPO$_4$,\textsuperscript{51,59,60} The \( \sim 135^\circ \) peak also matches quartz-type GaPO$_4$.\textsuperscript{54,61} Although the smaller Ga–O–P angle (\( \sim 120^\circ \)) is not found at room temperature, the fact that GaPO$_4$ is isomorphic with InPO$_4$ at high pressure suggests this type of bond could manifest under non-equilibrium growth conditions.\textsuperscript{52} It is worth noting that calculated M–O bond lengths for the M–O–P topology (Fig. 5b) are noticeably shorter than in bulk MPO$_4$. This is probably indicative of the additional geometric constraint placed on our system by the underlying InP/GaP lattice.

In contrast with the oxides, the angular distributions for the M–[OH]–M bridge (Fig. 5e) do not exhibit additional peak structure, but are normally distributed about an angle of 130–135\(^\circ\). This suggests that in our hydroxide simulations, the oxygen complexes do not have multiple preferred hybridizations. The peak is a good match to bulk In(OH)$_3$ but differs significantly from Ga(OH)$_3$, which adopts a different oxygen environment that is apparently not captured by our calculations. In addition, the calculated M–O bond lengths for M–[OH]–M (Fig. 5f) are shorter than in bulk M(OH)$_3$, much as we saw for the M–O–P topology in Fig. 5b. Note the wide distribution of Ga–O bond lengths in Fig. 5f, which is a consequence of the symmetry-breaking distortion described earlier.

V. SURFACE ELECTRONIC STRUCTURE

To determine the effect of adsorption on the surface electronic structure, we calculated projected densities of states (PDOS) for atoms in the local oxygen bond environments of several of our tested InP/GaP(001) surfaces. For brevity, we only present results for InP(001) here. Select results for GaP(001) are provided in the supplementary information;\textsuperscript{63} it should be noted that there is generally qualitative agreement between the two species. The PDOS for select distinct bond topologies are shown in Figs. 6–9. Each of the local bond topologies demonstrates unique electronic signatures that should permit identification using available experimental techniques.

For comparison with the bulk and surface band edges, the Figures also show the density of states of bulk InP, as well as the total PDOS of the surface atoms in the clean mixed-dimer (2\( \times \)4) and the clean (1\( \times \)2) dimer surfaces (Figs. 6a, 7a, 9a). The presence of the clean surfaces changes the character and position of the band edges with respect to the bulk, particularly for the conduction band, resulting in a shrinking of the gap. The (1\( \times \)2) dimer surface also shows a localized donor level due to dangling bond states, which disappears upon further surface adsorption.

A. Oxygen on In-rich InP(001)

Figure 6 displays the PDOS near the Fermi level for the In, O, and P atoms in a sampling of topologically unique In–O–P topologies. The valence signatures of the surfaces are similar, despite significant differences in the surface coordination and atomic arrangement. In several cases, the oxygen 2p states hybridize strongly with In and P neighbors to form an In/O/P peak at around −6.5 eV representing a three-center bond. This is seen for the In–O–P topologies on the mixed-dimer surface, as well as the X configuration (Fig. 6b–d,f), but does not appear in the clean surface (Fig. 6a). A second set of oxygen peaks with a degree of In and P hybrid character emerges in the vicinity of −4.0 eV. Notably, peaks in locations similar to the −4.0 eV and −6.5 eV peaks recorded in Fig. 6 were also identified in photoemission spectra of native oxide nucleation on InP(110).\textsuperscript{25,64} The amplitude of these peaks was found to directly correlate with oxygen exposure. Our results suggest that the observed oxide is InPO$_4$-like in nature, consisting of In–O–P local bond topologies. This is consistent with the structure of InP(110), which consists of exposed In–P surface dimers that can act as oxygen insertion sites. On the mixed-dimer \( \delta(2 \times 4) \) surface (Fig. 6b–e), there is also significant enhancement of the peak at the valence-band maximum, which appears regardless of absorption site. If localized both energetically and spatially, these states may translate to reduced hole mobility near the defect site, affecting photocathode performance. A combined experiment-theory effort is currently underway to confirm these findings.

The character of the primarily In-derived conduction band is also qualitatively similar across the tested samples. The band edges show little movement with respect to the clean surfaces in Fig. 6a, expressing only minor valence-band shifts towards the gap for the \( \delta \)1 and subsurface-oxygen (1\( \times \)2) dimer surfaces (Fig. 6g&h).

The PDOS for several of the In–O–In topologies is shown in Fig. 7. In contrast to the In–O–P topology, the surfaces in Fig. 7 all feature significant oxygen 2p peaks that are localized within the first few eV below the Fermi level that contain little In character. However, the location of these peaks is highly variable across tested surfaces. For some, such as the \( Y \) structure with \( \theta=1 \) (Fig. 7e) and the double-edge bound H–In–O–In–H bridge (Fig. 7h), the peak arises near the valence band maximum. In this case, the PDOS acts as a signature of hole carrier trapping, which we explore in detail below. For other surfaces, the peak is less localized and deeper in the valence by as much as 3 eV.

The position of the itinerant oxygen peaks in the In–O–In topologies turns out to be closely coupled to the In–O
FIG. 6. (Color online) PDOS for surface atoms of some local InP(001) bond topologies featuring O–P bonds. Black/red/green curves represent O/In/P densities of states. Highest occupied surface states are shown as arrows. Panel (a) shows the bulk density of states (filled region) alongside the surface PDOS for the clean mixed-dimer δ(2×4) (solid line; thick arrow) and the clean (1×2) dimer (dashed line; thin arrow) surfaces. The remaining configurations represent: (b-e) sites #2, #6, #9, and #1 on the mixed-dimer δ(2×4) (see Fig. 1); (f-g) the X and A1 dense-coverage surfaces (see Fig. 2a); and (h) the (1×2) dimer lattice with a subsurface oxygen inserted between In and P. Energies are referenced to the valence-band maximum of bulk InP.

Altering the chemical binding environment of the endpoint indium atoms can also change the In–O–In bond geometry and affect the location and character of the oxygen 2p valence peaks. To see this, we explored changing the In coordination by binding an atop –H to one or both In edges of the (1×2) surface with bridge oxygen (Figs. 7f–h). The effect of the termination of the dangling edge bonds is to drive the oxygen valence peaks towards the Fermi energy and to make the corresponding states more localized and atomic-like. Binding to both edge atoms strains the In–O–In bond more than binding to one of the edge atoms, which is reflected in higher oxygen 2p energies.

The In–O–In conduction states (Fig. 7) are more dispersive than for In–O–P (Fig. 6), as indicated by the shallower slope in the PDOS. Our results indicate that the position of the indium-derived surface conduction band edges in the In–O–In PDOS is largely determined by the availability of indium binding sites. More specifically, the existence of unsaturated dangling bonds on the bridge-terminating In atoms tends to systematically lower the band edge with respect to the bulk. For instance, this

FIG. 7. (Color online) PDOS for surface atoms of some local InP(001) bond topologies featuring In–O–In bonds. Black/red curves represent O/In densities of states. Highest occupied surface states are shown as arrows. See caption of Fig. 6 for an explanation of (a). The remaining configurations represent: (b–c) sites #5 and #4 on the mixed-dimer δ(2×4) (see Fig. 1); (d–e) the A1 and Y dense-coverage surfaces (see Fig. 2a); and (f–h) the (1×2) dimer lattice with a surface bridge oxygen and with no atop H, with one atop H, and with two atop H, respectively. Energies are referenced to the valence-band maximum of bulk InP.

bond distance and In–O–In bond angle, which are listed alongside the PDOS for each of the structures in Fig. 7. Larger angles and longer bond distances tend to drive the oxygen states towards the valence band maximum, likely because this weakens the covalent bonding character in the mixed ionic-covalent In–O bond, making the oxygen states more atomic-like. The shift is accompanied by an increase in the localization and a decrease in the indium hybrid character of the peak. The link between In–O–In bond geometry and the location of the oxygen 2p valence peak is explored more fully in Fig. 8, for which the In–In distance in the (1×2) dimer with an In–O–In bridge was fixed at different values across the bridge. Remaining atoms were allowed to relax under the constraint. Although the effect of compression on the PDOS is slight, possibly because the In–O bond distance does not change appreciably, expansion sharply shifts the oxygen 2p peak towards the valence band maximum. For 20% expansion (Fig. 8e), which corresponds approximately to the bulk In–In distance, peak locations are similar those found for the Y oxide with θ=1 (Fig. 7a).
FIG. 8. (Color online) PDOS for surface In and O atoms of InP(001) involved in a bridge y In–O–In bond configuration for $\theta=0.5$ under various levels of strain. With reference to the equilibrium In–In distance, the panels represent: (a) 20% compression; (b) 10% compression; (c) the equilibrium distance; (c) 10% tension; and (d) 20% tension. Black/red curves represent O/In densities of states. Energies are referenced to the valence-band maximum of bulk InP.

...the position of the conduction band edge is determined by the same rules as for In–O–In, with unsaturated bonds closing the gap. For example, in Fig. 9f–h, the location of the donor-like state shifts from a deep donor (Fig. 9f) to a shallow donor (Fig. 9g) to no donor state outside the conduction band (Fig. 9h) upon gradual introduction of two atop H atoms on the edges of the In–[OH]–In bridge structure. Similarly, the $Y$ configuration, which lacks dangling bonds, has a higher conduction-band edge than the $(1\times2)$ In–[OH]–In bridge (compare Figs. 9e&f).

The oxygen adatom in the In–[OH]–In bridge (Fig. 9a–c, f–g) contributes three primary signatures to the PDOS. The first, a peak at around $-7.0$ to $-7.5$ eV, is associated with the O–H bond but contains minor In character. Interestingly, this peak does not appear in the In–OH adatom descriptions (Fig. 9c&i), although an analogous peak with P character is seen for P–OH (Fig. 9d). A second, shallower peak, associated with the In–O bond, is found for most of the surfaces near $-6$ eV. Finally, there is a signature at around $-3$ eV that is predominantly oxygen-derived (for the In–OH descriptions, this peak is closer to $-1.5$ eV).

VI. DISCUSSION

The (100) surface of GaP and InP is characteristic among the common low-energy surfaces in that it features $M–M$ surface dimerization. Our results suggest that adsorption of oxygen or hydroxyl is likely to break the surface $M–M$ dimerization that is characteristic of the (001) surface. Of the possible oxygen local bond configurations, two should dominate oxygen chemisorption and subsequent native oxide nucleation based on their relative stability: $M–O–P$ and $M–O–M$. Notably, these same two topologies have been suggested based on x-ray photoemission spectra of InP(001) 23, as well as calculations on InP nanowires 65. Both topologies can also branch to form an additional $M–O$ bond with some cost in energy. The strength of the Ga–O bond relative to In–O means GaP should show a clear thermodynamic preference for $M–O–M$ over $M–O–P$, whereas InP is approximately even for the two (with $M–O–P$ perhaps slightly favored over $M–O–M$). Although this does not necessarily predict which bulk oxide will grow natively under equilibrium conditions, it does suggest that the initial pre-nucleation of sub-monolayer oxide growth on GaP(001) should favor a Ga$_2$O$_3$-like structure, whereas a combination of In$_2$O$_3$- and InPO$_4$-like structures are expected on InP(001). On other surfaces where $M–M$ dimers are not present, $M–O–P$ bonds should dominate. These conclusions are consistent with suggestions from several experiments on InP and GaP oxidation 23,24,26,66–69. However, we should note that for the (100) surface, $M–O–M$ is an exclusively surface-adsorbed topology, whereas $M–O–P$ features oxygen incorporated in the subsurface.

It is therefore likely that the kinetics of oxygen incor-
FIG. 9. (Color online) PDOS for surface atoms of local InP(001) bond topologies for several of the OH-decorated surfaces. Black/red/green curves represent O/In/P densities of states. Highest occupied surface states are shown as arrows. See caption of Fig. 6 for an explanation of (a). The remaining configurations represent: (b–d) sites #5, #3, and #1 on the mixed-dimer δ(2×4) (see Fig. 1); (e) the Y dense-coverage surfaces (see Fig. 2b); (f–h) the (1×2) dimer lattice with a surface bridge hydroxyl and with no atop H, with one atop H, and with two atop H, respectively; and (i) the (1×2) dimer lattice with an atop OH. Energies are referenced to the valence-band maximum of bulk InP.

Incorporation may play a significant role in determining oxide morphology, yet our simulations do not provide further information on subsurface diffusion barriers for oxygen or gallium/indium. As such, we hesitate to make definitive conclusions about oxide growth beyond the first monolayer based on thermodynamics alone. It is worth emphasizing that kinetics are known to be relevant for oxide growth on III-V semiconductors at ambient temperatures, where conditions far from equilibrium lead to amorphization or formation of metastable compositions that differ from the high-temperature variants.24–26,27,29 This means that in real samples, lowest-energy oxygen topologies are likely to coexist with the additional topologies we study here. A detailed investigation of the kinetics of oxygen incorporation presents an opportunity for future study that may offer additional insight.

Results for the hydroxide show the M–[OH]–M bridge and M–OH atop as the dominant bonding configurations for highly M-rich surfaces (we can neglect the atop P–OH if we assume that the surface phosphorus concentration is small). In this case, there is little distinction between GaP and InP in terms of the relative stability of these two. For M–OH, significant stabilization is seen for neighboring pairs of atop OH groups, which can hydrogen bond with one another. Further stabilization of the atop OH is expected in solution, where water can directly hydrogen-bond with the adsorbate. Comparison of the formation energies for the oxide and hydroxide (Figs. 3 and 4) points to the energetic stability of the hydroxide relative to the oxide. Barring other thermodynamic contributions, this indicates a driving force for hydroxylation not only of the clean surface in alkaline solution, but also of the oxide surface via protonation.

Signatures in the electronic structure point to important implications for the M–O–M topology (Figs. 7 and 8). In particular, M–O–M can give rise to hole traps if the bond is strained, either by symmetry constraints or by activation of surface modes, or if the M atoms on either side of the oxygen bridge are bound to a monovalent adsorbate (H or OH). In light of the connection between the M–O–M bond geometry and the character of the valence band maximum, activation of surface phonon modes or fluctuations in the surface bond chemistry could lead to significant reductions in the surface hole mobility of an oxygen-decorated GaP/InP photoelectrode. In addition, we find that the M–O–M and M–[OH]–M bridge topologies, as well as M–M surface dimers, can introduce shallow donor states in the gap if there are unsaturated bonds on the edge M atoms. It is worth emphasizing that in those instances where the character and position of the band edges are significantly affected, as we see especially for the M–O–M bond topology, the oxygen adsorbate and its immediate environment will largely determine the surface chemistry. This points to the importance of including oxygen-derived surface adsorbates in realistic models of GaP or InP surfaces.

The existence of the hole trap on the M–O–M bond topology provides a compelling possible connection to the observed loss of cathodic protection in GaP/InP-based electrodes in operating photoelectrochemical cells. This conclusion derives in part from experiments which found that cathodic corrosion requires exciton generation, and that simple injection of electrons via application of current in the dark did not lead to electrode degradation.15 This implies that the presence of holes is key to the corrosion mechanism, which probably derives from a shift in the local potential from regional hole buildup that is not compensated by the electrolyte solution. Furthermore, no hole traps are observed for M–[OH]–M bridges, so it is reasonable to conclude that the introduction of hole traps may be connected to proton donation from the low-energy hydroxylated surface, from which M–O–M bridges might be formed. Notably, hole traps have been connected to photocorrosion in other semiconductor materials.70–72

The uniformity of our results across the tested samples allows us to map features in the electronic structure to
bond topologies, as well as to specific bond geometries or bond chemistries within those topologies. This suggests that a local topological model may reproduce many of the key characteristics of the early stages of surface oxide and hydroxide formation. This is supported by the qualitative analysis of the common structural features in our tested surfaces (Fig. 5), which were found to closely correlate with analogous characteristics of the amorphous and crystalline bulk oxide phases. For example, the bond angle and length distributions are in near perfect agreement with the bulk amorphous oxide In$_2$O$_3$, despite the fact that our models consider only monolayer or submonolayer oxygen coverage. For the $M$–O–M topology, the observed dependence of the band-edge states on lattice strain and local bond chemistry suggests that the key functional characteristics of the surface should be reproduced as long as these features are accounted for in the model. We should mention that there are instances where only some of the local structural characteristics of the bulk phases are reproduced by our simulations, namely, $M$–O–P and $M$–[OH]–M. Fortunately, for these topologies, the electronic structure in the valence band region generally carries a weaker dependence on the local structure. Since the chemical properties of the surface are ultimately largely dependent on the electronic structure near the HOMO/LUMO levels (corresponding to the valence and conduction band edges), these should be preserved in the local model. We point out that in the case of InP, the connection between electronic structure and local morphology was successfully exploited in Ref. 29 to categorize amorphous native surface oxides based on x-ray photoelectron spectral features similar to those found for crystalline bulk phases. An analogous approach has also been proposed to assign oxides of GaAs$^{53}$.

VII. SUMMARY AND CONCLUSIONS

In summary, we have performed extensive total-energy calculations on a wide variety of known and theoretically obtained oxide- and hydroxide-decorated surfaces of InP/GaP(001). Although realistic oxygen-rich polar III-V surfaces are expected to show a richly complex surface morphology, our results demonstrate that essential features in the morphology and electronic structure can be rationalized based on topological and geometric characteristics of the local adsorbate environment. This offers a simple and straightforward strategy for modeling the interplay between surface morphology, electronic structure, and chemistry in realistic oxygen- and hydroxyl-decorated (001) surfaces of GaP and InP. In addition, the local nature of the model means many of our conclusions are likely to be transferable to surfaces other than (001), as well as step edges and boundaries, provided similar bond topologies exist. We identify four principal adsorbate bond topologies ($M$–O–$M$, $M$–O–P, $M$–[OH]–$M$, $M$–OH), each of which carries distinctive signatures in the electronic structure. The $M$–O–M topology can significantly impair the mobility of hole carriers when strained mechanically, thermally, or by high oxygen coverage, or when the dangling bonds on the $M$ atoms are saturated. The resulting hole traps may contribute to the observed photocorrosion of GaP/InP-based electrode materials in operating photoelectrochemical cells. The electronic signatures associated with each of the bond topologies should be detectable using surface-sensitive spectroscopic methods (including X-ray techniques), providing a means for experimental identification of local structural topologies in native oxide films and offering insight into microscopic mechanisms of surface oxide nucleation. Such efforts are currently underway. By mapping the surface electronic structure to the adsorbate binding configuration, our results may augment experimental efforts towards improved III-V-based electrodes for photoelectrochemistry, as well as for additional applications where the formation of native oxide and hydroxide films may impact desired functionality.

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